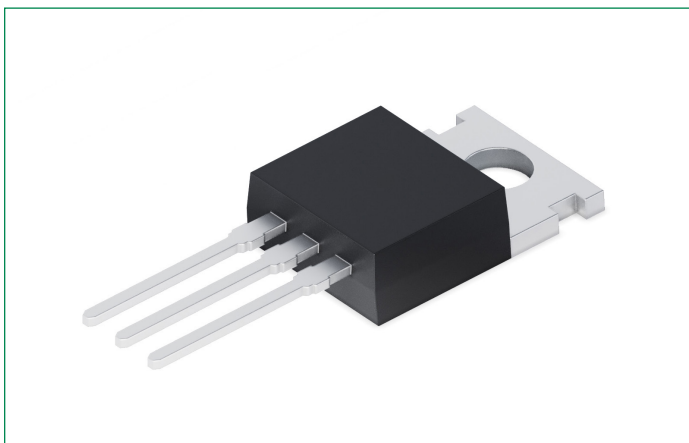


IOTP64N10L2

100 V, 32 mΩ, 64 A Linear L2™ Power MOSFET w/Extended FBSOA

N-Channel Enhancement Mode



Features & Benefits:

- Designed for Linear Operation
- International Standard Package
- Avalanche Rated
- Guaranteed FBSOA at $T_C = 75\text{ }^\circ\text{C}$
- Easy to Mount
- Space Savings
- High Power Density

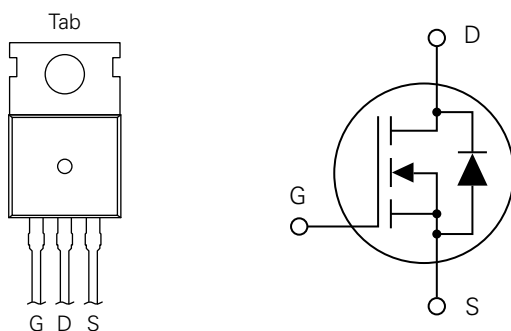
Applications:

- Solid State Circuit Breakers
- Soft Start Controls
- Linear Amplifiers
- Programmable Loads
- Current Regulators

Product Summary

Characteristic	Value	Unit
V_{DSS}	100	V
I_{D25}	64	A
$R_{DS(on)}$	≤ 32	mΩ

Pinout Diagram TO-220 (IOTP)



G: Gate; **D:** Drain; **S:** Source; **Tab:** Drain

Maximum Ratings

Symbol	Characteristic	Conditions	Value	Unit
V_{DSS}	Drain-Source Voltage	$T_J = 25\text{ °C to }150\text{ °C}$	100	V
V_{DGR}	Drain-Gate Voltage	$T_J = 25\text{ °C to }150\text{ °C}, R_{GS} = 1\text{ M}\Omega$	100	V
V_{GSS}	Gate-Source Voltage	Continuous	± 20	V
V_{GSM}		Transient	± 30	
I_{D25}	Drain Current	$T_C = 25\text{ °C}$	64	A
I_{DM}		$T_C = 25\text{ °C}, \text{Pulse Width Limited by } T_{JM}$	140	
I_A	Avalanche Current	$T_C = 25\text{ °C}$	32	A
E_{AS}	Avalanche Energy	$T_C = 25\text{ °C}$	2	J
P_D	Power Dissipation	$T_C = 25\text{ °C}$	357	W
T_J	Operating Junction Temperature	–	–55 to +150	°C
T_{JM}	Maximum Junction Temperature	–	150	
T_{stg}	Storage Temperature	–	–55 to +150	
T_L	Maximum Lead Temperature for Soldering	1.6 mm (0.062 in.) from Case for 10 s	300	°C
M_d	Mounting Torque	–	1.13 / 10	Nm/lb.in
W	Weight	–	3	g

Thermal Characteristics

Symbol	Characteristic	Value			Unit
		Min.	Typ.	Max.	
$R_{th, JC}$	Thermal Resistance, Junction-to-Case	–	–	0.35	°C/W
$R_{th, CS}$	Thermal Resistance, Case-to-Heatsink	–	0.50	–	°C/W

Electrical Characteristics – Static ($T_J = 25\text{ °C}$ unless otherwise specified)

Symbol	Characteristic	Conditions	Value			Unit
			Min.	Typ.	Max.	
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250\text{ }\mu\text{A}, V_{GS} = 0\text{ V}$	100	–	–	V
$V_{GS(th)}$	Gate Threshold Voltage	$I_D = 250\text{ }\mu\text{A}, V_{GS} = V_{DS}$	2.5	–	4.5	V
I_{GSS}	Gate-Source Leakage Current	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	–	–	± 100	nA
I_{DSS}	Drain-Source Leakage Current	$V_{DS} = V_{DSS}, V_{GS} = 0\text{ V}$	–	–	5	μA
		$V_{DS} = V_{DSS}, V_{GS} = 0\text{ V}, T_J = 125\text{ °C}$	–	–	25	μA
$R_{DS(on)}$	Drain-Source On-Resistance ¹	$V_{GS} = 10\text{ V}, I_D = 0.5 \times I_{D25}$	–	–	32	m Ω

Note 1: Pulse test, $t \leq 300\text{ }\mu\text{s}$, duty cycle, $d \leq 2\%$

Electrical Characteristics – Dynamic ($T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Conditions	Value			Unit
			Min.	Typ.	Max.	
g_{fs}	Transconductance ¹	$V_{DS} = 10\text{ V}, I_D = 0.5 \times I_{D25}$	21	27	33	S
R_{Gi}	Gate Input Resistance	–	–	1.2	–	Ω
C_{iss}	Input Capacitance	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	–	3620	–	pF
C_{oss}	Output Capacitance		–	720	–	
C_{rss}	Reverse Transfer Capacitance		–	235	–	
$Q_{g(on)}$	Total Gate Charge	$V_{GS} = 10\text{ V}, V_{DS} = 0.5 \times V_{DSS},$ $I_D = 0.5 \times I_{D25}$	–	100	–	nC
Q_{gs}	Gate-Source Charge		–	16	–	
Q_{gd}	Gate-Drain Charge		–	45	–	
$t_{d(on)}$	Turn-on Delay Time	Resistive Switching $V_{GS} = 10\text{ V}, V_{DS} = 0.5 \times V_{DSS},$ $I_D = 0.5 \times I_{D25}, R_{G(ext)} = 0\ \Omega$	–	14	–	ns
t_r	Rise Time		–	27	–	
$t_{d(off)}$	Turn-off Delay Time		–	38	–	
t_f	Fall Time		–	11	–	

Note 1: Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle, $d \leq 2\%$

Safe Operating Area Specification

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
SOA	$V_{DS} = 100\text{ V}, I_D = 2.15\text{ A}, T_C = 75\text{ }^\circ\text{C}, T_p = 5\text{ s}$	215	–	–	W

Source-Drain Diode Characteristics ($T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Conditions	Value			Unit
			Min.	Typ.	Max.	
I_S	Continuous Diode Forward Current	$V_{GS} = 0\text{ V}$	–	–	64	A
I_{SM}	Diode Pulse Current	Repetitive, Pulse Width Limited by T_{JM}	–	–	256	A
V_{SD}	Diode Forward Voltage ¹	$I_F = I_S, V_{GS} = 0\text{ V}$	–	–	1.4	V
t_{rr}	Reverse Recovery Time	$I_F = 32\text{ A}, -di/dt = 100\text{ A}/\mu\text{s},$ $V_R = 50\text{ V}, V_{GS} = 0\text{ V}$	–	180	–	ns
I_{RM}	Reverse Recovery Current		–	16.2	–	A
Q_{RM}	Reverse Recovery Charge		–	1.46	–	μC

Note 1: Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle, $d \leq 2\%$

Characteristic Curves

Fig. 1. Output Characteristics @ $T_J = 25\text{ }^\circ\text{C}$

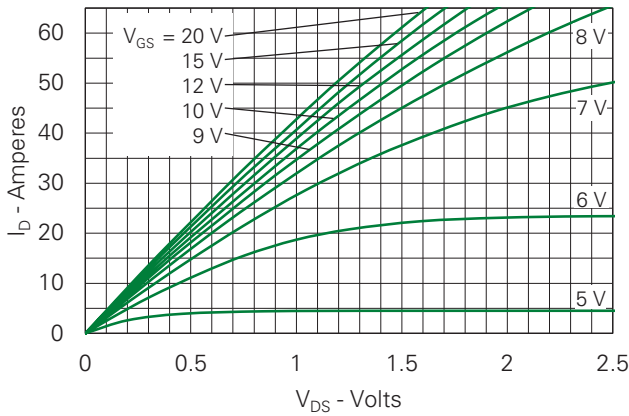


Fig. 2. Extended Output Characteristics @ $T_J = 25\text{ }^\circ\text{C}$

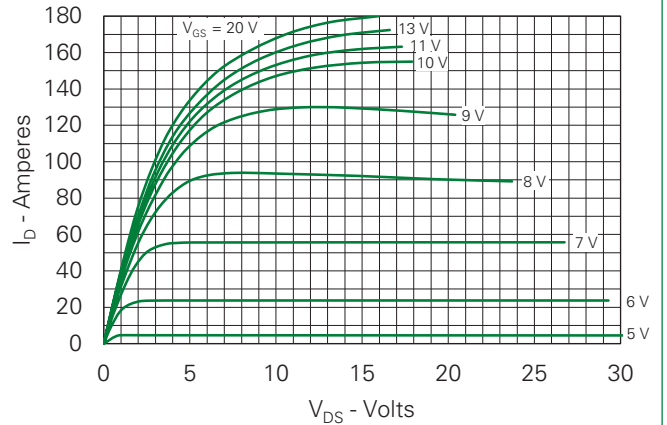


Fig. 3. Output Characteristics @ $T_J = 125\text{ }^\circ\text{C}$

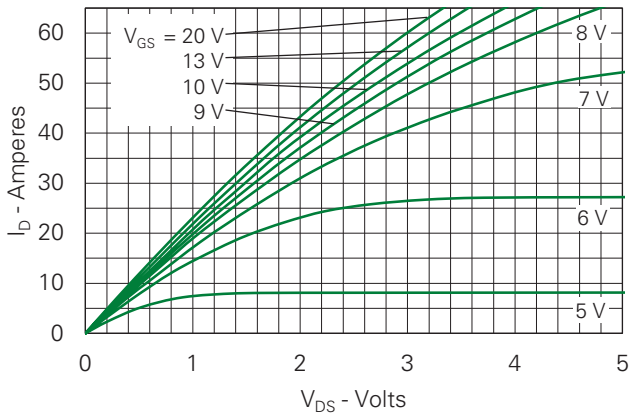


Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 32\text{ A}$ Value vs. Junction Temperature

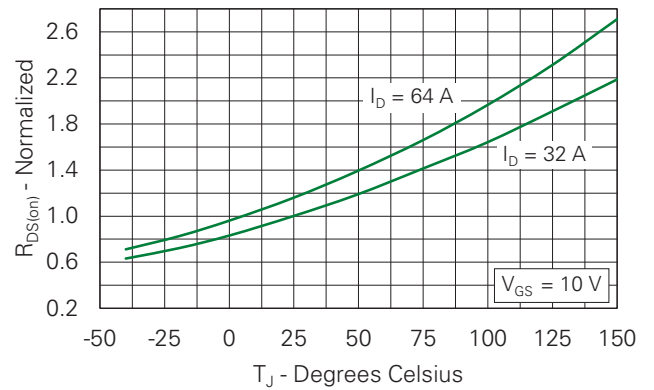


Fig. 5. $R_{DS(on)}$ Normalized to $I_D = 32\text{ A}$ Value vs. Drain Current

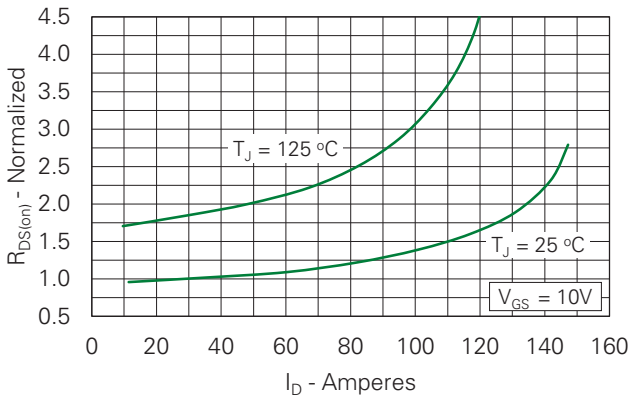


Fig. 6. Maximum Drain Current vs. Case Temperature

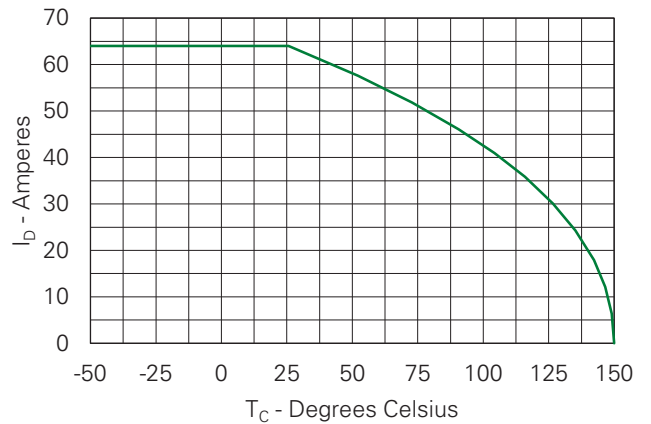


Fig. 7. Input Admittance

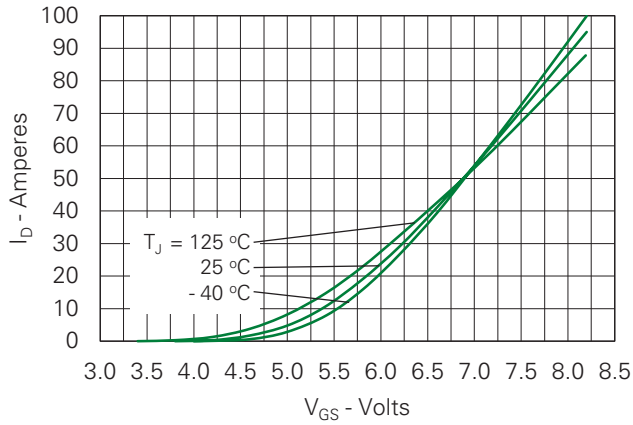


Fig. 8. Transconductance

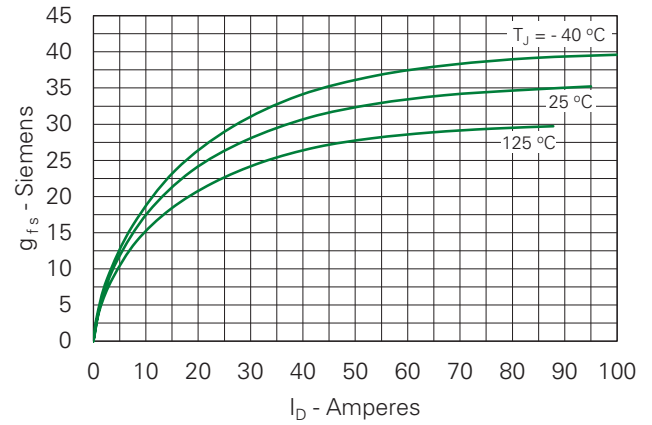


Fig. 9. Forward Voltage Drop of Intrinsic Diode

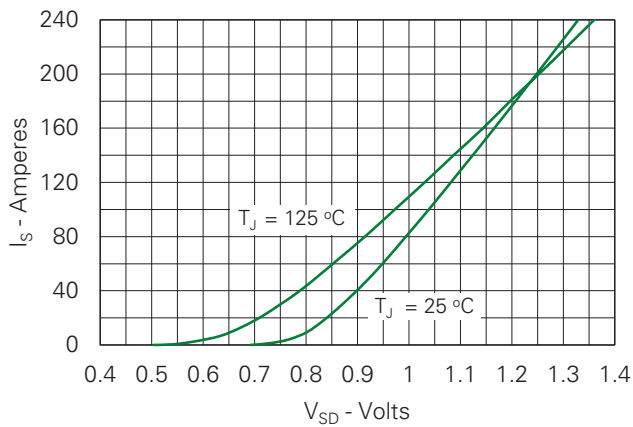


Fig. 10. Gate Charge

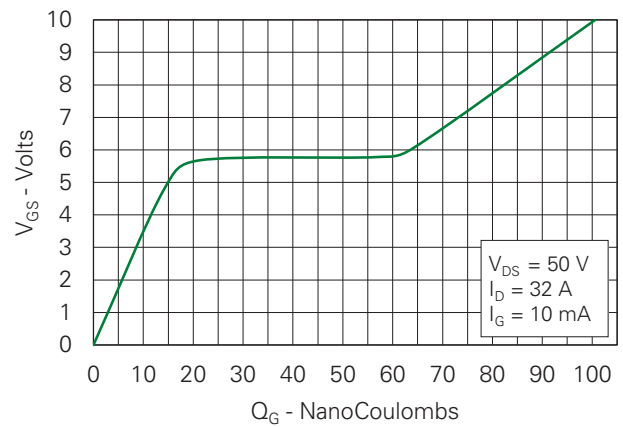


Fig. 11. Capacitance

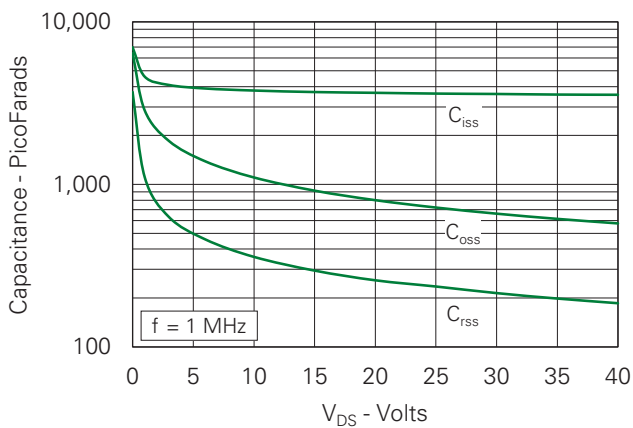


Fig. 12. Maximum Transient Thermal Impedance

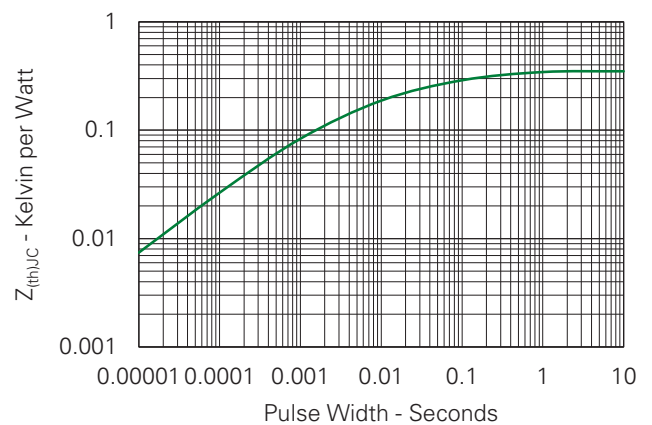


Fig. 13. Forward-Bias Safe Operating Area @ $T_c = 25^\circ\text{C}$

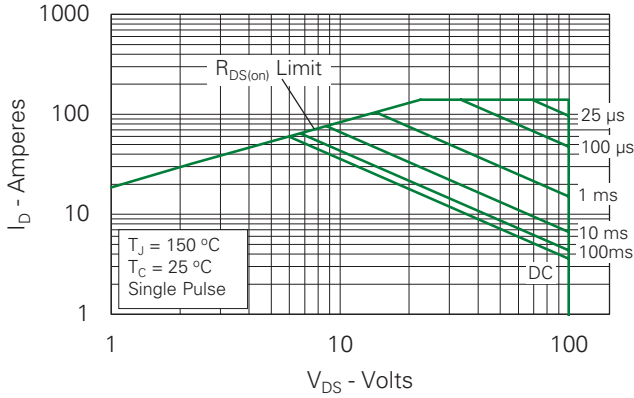
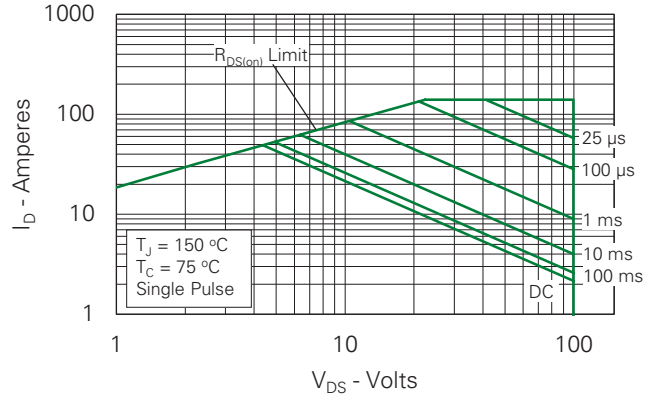
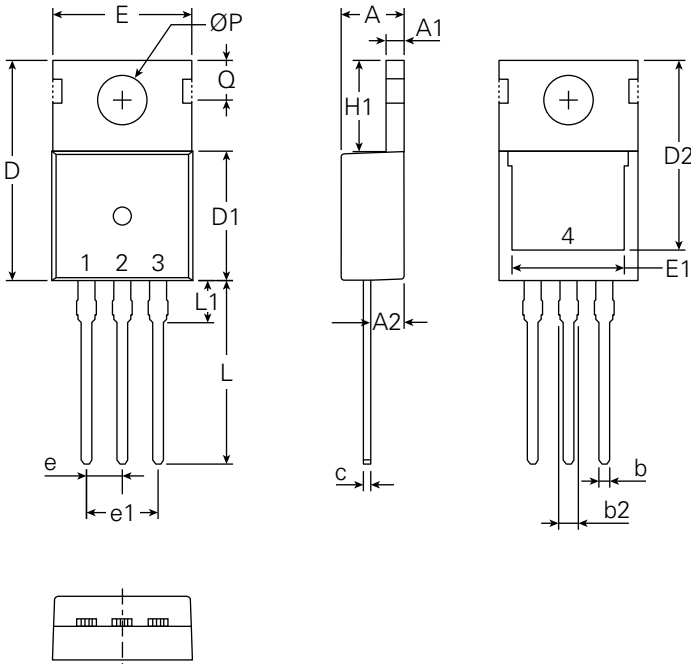


Fig. 14. Forward-Bias Safe Operating Area @ $T_c = 75^\circ\text{C}$



Part Outline Drawing TO-220 (IXTP)



- 1 - Gate
- 2,4 - Drain
- 3 - Source

Symbol	Inches			Millimeters		
	Min.	Typical	Max.	Min.	Typical	Max.
A	0.169	-	0.185	4.30	-	4.70
A1	0.047	-	0.055	1.20	-	1.40
A2	0.079	-	0.106	2.00	-	2.70
b	0.024	-	0.039	0.60	-	1.00
b2	0.045	-	0.057	1.15	-	1.45
c	0.014	-	0.026	0.35	-	0.65
D	0.587	-	0.626	14.90	-	15.90
D1	0.335	-	0.370	8.50	-	9.40
(D2)	0.500	-	0.531	12.70	-	13.50
E	0.382	-	0.406	9.70	-	10.30
(E1)	0.283	-	0.323	7.20	-	8.20
e	0.100 BSC			2.45 BSC		
e1	0.200 BSC			5.08 BSC		
H1	0.244	-	0.268	6.20	-	6.80
L	0.492	-	0.547	12.50	-	13.90
L1	0.110	-	0.154	2.80	-	3.90
ØP	0.134	-	0.150	3.40	-	3.80
Q	0.106	-	0.126	2.70	-	3.20

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